

DUAL 50V NPN & 40V PNP LOW SATURATION TRANSISTOR COMBINATION

Features

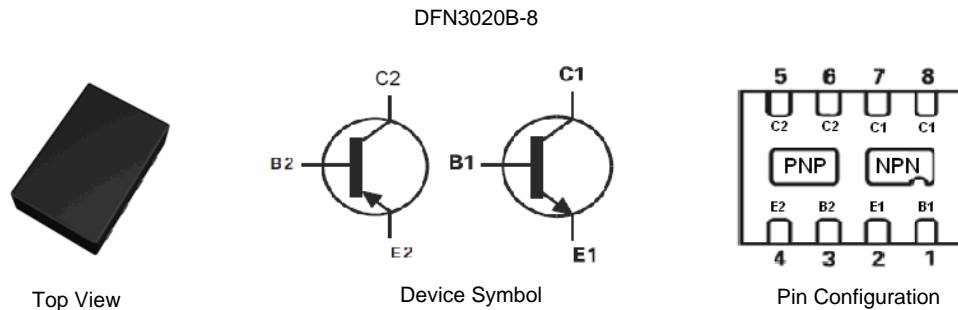
- NPN Transistor
 - $V_{CE0} = 50V$
 - $R_{SAT} = 68\ m\Omega$
 - $I_C = 4A$
- PNP Transistor
 - $V_{CE0} = -40V$
 - $R_{SAT} = 104\ m\Omega$
 - $I_C = -3A$
- $I_C = 4A$ Continuous Collector Current
- Low Saturation Voltage (100mV max @ 1A -- NPN)
- h_{FE} characterized up to 6A
- **Lead, Halogen, and Antimony Free/RoHS Compliant (Note 1)**
- **"Green" Devices (Note 2)**

Mechanical Data

- Case: DFN3020B-8
- Terminals: Pre-Plated NiPdAu leadframe
- Nominal package height: 0.8mm
- UL Flammability Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Solderable per MIL-STD-202, Method 208
- Weight: 0.013 grams (approximate)

Applications

- DC – DC Converters
- Charging circuits
- Power switches
- Motor control
- CCFL Backlighting circuits



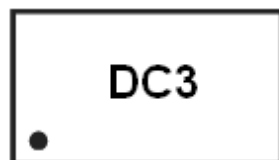
Ordering Information

Product	Status	Marking	Reel size (inches)	Tape width (mm)	Quantity per reel
ZXTC6719MCTA	Active	DC3	7	8	3000

- Notes:
1. No purposefully added lead. Halogen and Antimony Free.
 2. Diodes Inc's "Green" Policy can be found on our website at <http://www.diodes.com>

Marking Information

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DC3 = Product type Marking Code
Dot denotes Pin 1

Maximum Ratings

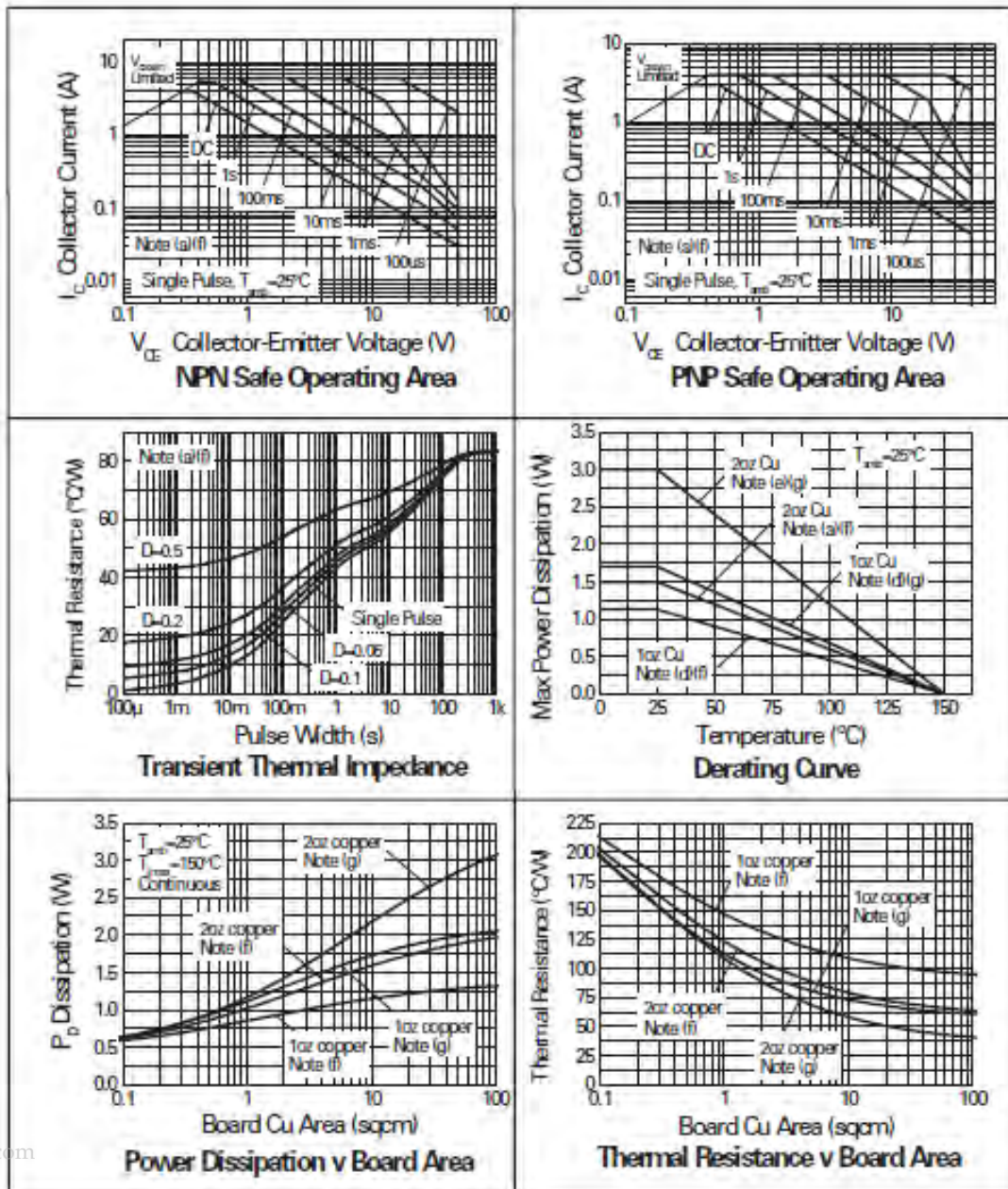
Parameter	Symbol	NPN	PNP	Unit
Collector-Base Voltage	V_{CBO}	100	-50	V
Collector-Emitter Voltage	V_{CEO}	50	-40	V
Emitter-Base Voltage	V_{EBO}	7.5	-7.5	V
Peak Pulse Current	I_{CM}	6	-4	A
Continuous Collector Current (a) (f)	I_C	4	-3	A
Base Current	I_B		1	A

Thermal Characteristics

Characteristic	Symbol	Value	Unit
Power Dissipation at $T_A = 25^\circ\text{C}$ (a) (f)		1.5	W
Linear Derating Factor	P_D	12	mW/ $^\circ\text{C}$
Power Dissipation at $T_A = 25^\circ\text{C}$ (b) (f)		2.45	W
Linear Derating Factor	P_D	19.6	mW/ $^\circ\text{C}$
Power Dissipation at $T_A = 25^\circ\text{C}$ (c) (f)		1	W
Linear Derating Factor	P_D	8	mW/ $^\circ\text{C}$
Power Dissipation at $T_A = 25^\circ\text{C}$ (d) (f)		1.13	W
Linear Derating Factor	P_D	9	mW/ $^\circ\text{C}$
Power Dissipation at $T_A = 25^\circ\text{C}$ (d) (g)		1.7	W
Linear Derating Factor	P_D	13.6	mW/ $^\circ\text{C}$
Power Dissipation at $T_A = 25^\circ\text{C}$ (e) (g)		3	W
Linear Derating Factor	P_D	24	mW/ $^\circ\text{C}$
Junction to Ambient (a) (f)	$R_{\theta JA}$	83.3	$^\circ\text{C}/\text{W}$
Junction to Ambient (b) (f)	$R_{\theta JA}$	51	$^\circ\text{C}/\text{W}$
Junction to Ambient (c) (f)	$R_{\theta JA}$	125	$^\circ\text{C}/\text{W}$
Junction to Ambient (d) (f)	$R_{\theta JA}$	111	$^\circ\text{C}/\text{W}$
Junction to Ambient (d) (g)	$R_{\theta JA}$	73.5	$^\circ\text{C}/\text{W}$
Junction to Ambient (e) (g)	$R_{\theta JA}$	41.7	$^\circ\text{C}/\text{W}$
Operating and Storage Temperature Range	T_J, T_{STG}	-55 to +150	$^\circ\text{C}$

- Notes:
- For a dual device surface mounted on 8 sq cm single sided 2 oz copper on FR4 PCB, in still air conditions **with all exposed pads attached**. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.
 - Measured at $t < 5$ secs for a dual device surface mounted on 8 sq cm single sided 2 oz copper on FR4 PCB, in still air conditions **with all exposed pads attached**. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.
 - For a dual device surface mounted on 8 sq cm single sided 2 oz copper on FR4 PCB, in still air conditions **with minimal lead connections only**.
 - For a dual device surface mounted on 10 sq cm single sided 1 oz copper on FR4 PCB, in still air conditions **with all exposed pads attached**. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.
 - For a dual device surface mounted on 85 sq cm single sided 2 oz copper on FR4 PCB, in still air conditions **with all exposed pads attached**. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.
 - For a dual device with one active die.
 - For dual device with 2 active die running at equal power.

Thermal Characteristics and Derating information



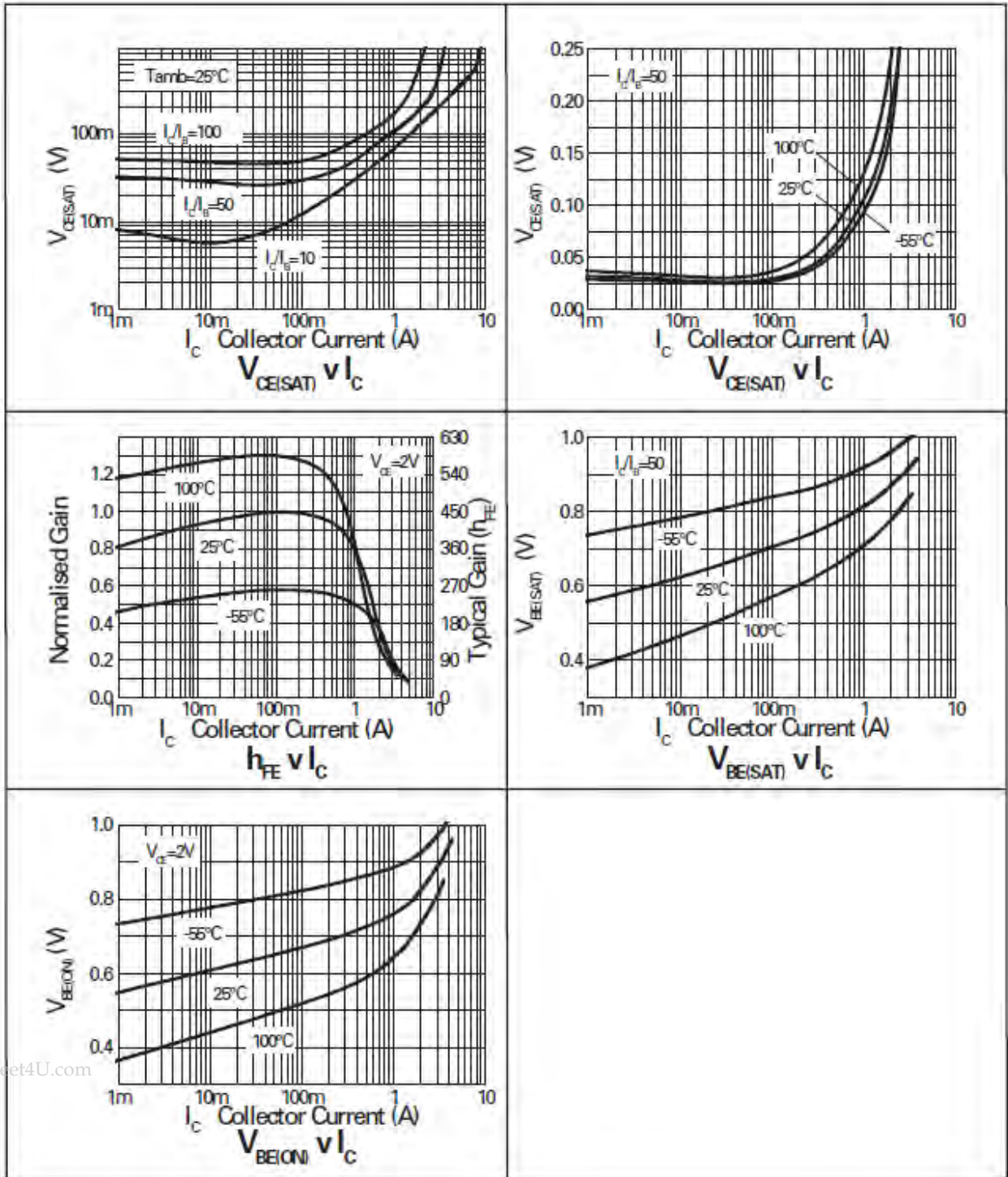
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Electrical Characteristics, NPN Transistor (at $T_A = 25^\circ\text{C}$ unless otherwise specified)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
Collector-Base Breakdown Voltage	$V_{(BR)CBO}$	100	190	-	V	$I_C = 100\mu\text{A}$
Collector-Emitter Breakdown Voltage (Note 3)	$V_{(BR)CEO}$	50	65	-	V	$I_C = 10\text{mA}$
Emitter-Base Breakdown Voltage	$V_{(BR)EBO}$	7.5	8.2	-	V	$I_E = 100\mu\text{A}$
Collector Cutoff Current	I_{CBO}	-	-	25	nA	$V_{CB} = 80\text{V}$
Emitter Cutoff Current	I_{EBO}	-	-	25	nA	$V_{EB} = 6\text{V}$
Collector Emitter Cutoff Current	I_{CES}	-	-	25	nA	$V_{CES} = 40\text{V}$
Static Forward Current Transfer Ratio (Note 3)	h_{FE}	200 300 200 100 -	400 450 400 225 40	- - - - -	-	$I_C = 10\text{mA}, V_{CE} = 2\text{V}$ $I_C = 200\text{mA}, V_{CE} = 2\text{V}$ $I_C = 1\text{A}, V_{CE} = 2\text{V}$ $I_C = 2\text{A}, V_{CE} = 2\text{V}$ $I_C = 6\text{A}, V_{CE} = 2\text{V}$
Collector-Emitter Saturation Voltage (Note 3)	$V_{CE(sat)}$	- - - - -	10 70 145 115 225 270	20 100 200 220 300 320	mV	$I_C = 0.1\text{A}, I_B = 10\text{mA}$ $I_C = 1\text{A}, I_B = 5\text{mA}$ $I_C = 1\text{A}, I_B = 10\text{mA}$ $I_C = 2\text{A}, I_B = 50\text{mA}$ $I_C = 3\text{A}, I_B = 100\text{mA}$ $I_C = 4\text{A}, I_B = 200\text{mA}$
Base-Emitter Turn-On Voltage (Note 3)	$V_{BE(on)}$	-	0.94	1.00	V	$I_C = 4\text{A}, V_{CE} = 2\text{V}$
Base-Emitter Saturation Voltage (Note 3)	$V_{BE(sat)}$	-	1.00	1.05	V	$I_C = 4\text{A}, I_B = 200\text{mA}$
Output Capacitance	C_{obo}	-	12	20	pF	$V_{CB} = 10\text{V}, f = 1\text{MHz}$
Transition Frequency	f_T	100	165	-	MHz	$V_{CE} = 10\text{V}, I_C = 50\text{mA}, f = 100\text{MHz}$
Turn-on Time	t_{on}	-	170	-	ns	$V_{CC} = 10\text{V}, I_C = 1\text{A}$
Turn-off Time	t_{off}	-	750	-	ns	$I_{B1} = I_{B2} = 10\text{mA}$

Notes: 3. Measured under pulsed conditions.

NPN Characteristics



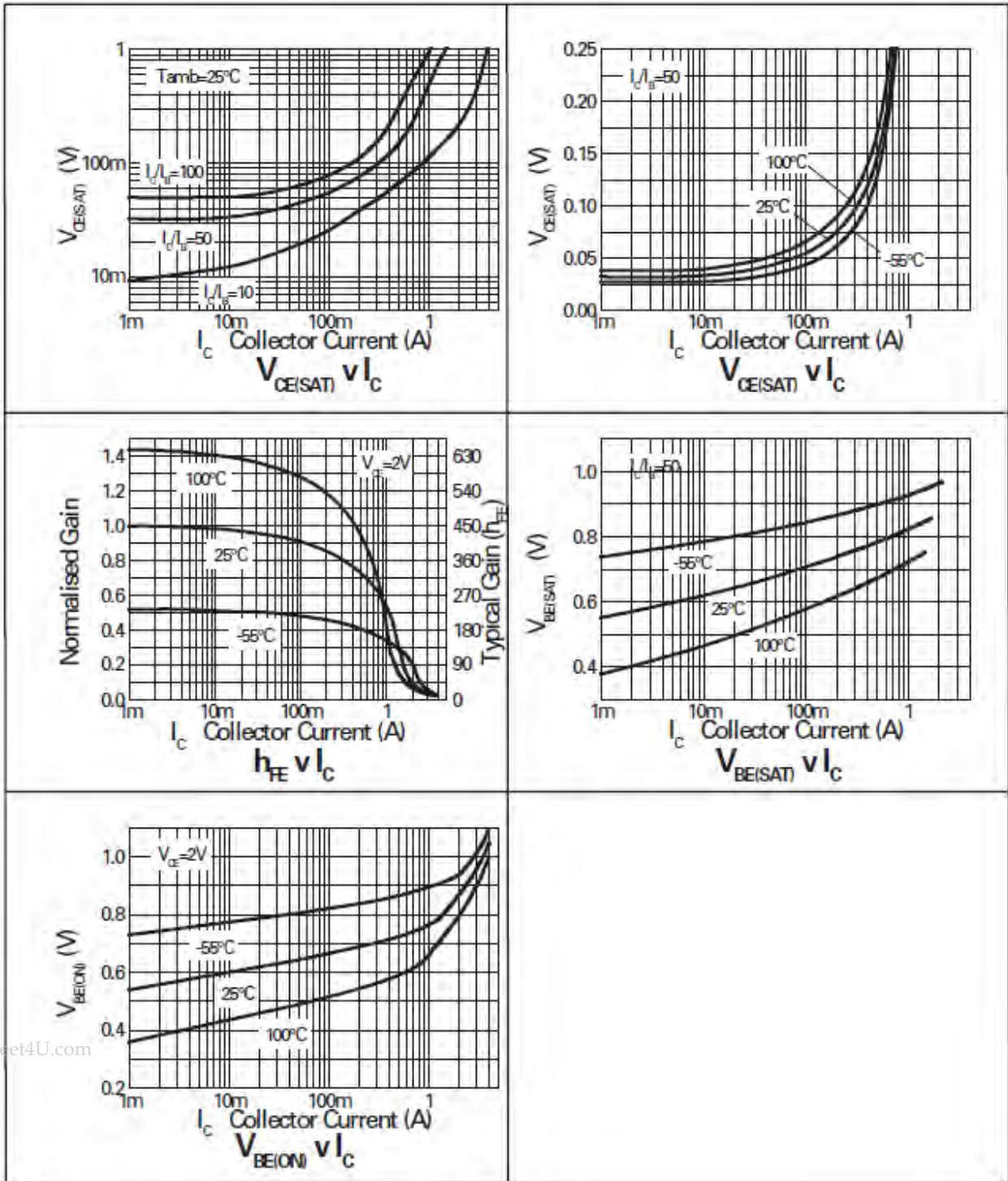
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Electrical Characteristics, PNP Transistor @ $T_A = 25^\circ\text{C}$ unless otherwise specified

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
Collector-Base Breakdown Voltage	$V_{(BR)CBO}$	-50	-80	-	V	$I_C = -100\mu\text{A}$
Collector-Emitter Breakdown Voltage (Note 4)	$V_{(BR)CEO}$	-40	-70	-	V	$I_C = -10\text{mA}$
Emitter-Base Breakdown Voltage	$V_{(BR)EBO}$	-7.5	-8.5	-	V	$I_E = -100\mu\text{A}$
Collector Cutoff Current	I_{CBO}	-	-	-25	nA	$V_{CB} = -40\text{V}$
Emitter Cutoff Current	I_{EBO}	-	-	-25	nA	$V_{EB} = -6\text{V}$
Collector Emitter Cutoff Current	I_{CES}	-	-	-25	nA	$V_{CES} = -32\text{V}$
Static Forward Current Transfer Ratio (Note 4)	h_{FE}	300 300 180 60 12	480 450 290 130 22	- - - - -	-	$I_C = -10\text{mA}, V_{CE} = -2\text{V}$ $I_C = -100\text{mA}, V_{CE} = -2\text{V}$ $I_C = -1\text{A}, V_{CE} = -2\text{V}$ $I_C = -1.5\text{A}, V_{CE} = -2\text{V}$ $I_C = -3\text{A}, V_{CE} = -2\text{V}$
Collector-Emitter Saturation Voltage (Note 4)	$V_{CE(sat)}$	- - - - -	-25 -150 -195 -210 -260	-40 -220 -300 -300 -370	mV	$I_C = -0.1\text{A}, I_B = -10\text{mA}$ $I_C = -1\text{A}, I_B = -50\text{mA}$ $I_C = -1.5\text{A}, I_B = -100\text{mA}$ $I_C = -2\text{A}, I_B = -200\text{mA}$ $I_C = -2.5\text{A}, I_B = -250\text{mA}$
Base-Emitter Turn-On Voltage (Note 4)	$V_{BE(on)}$	-	-0.89	-0.95	V	$I_C = -2.5\text{A}, V_{CE} = -2\text{V}$
Base-Emitter Saturation Voltage (Note 4)	$V_{BE(sat)}$	-	-0.97	-1.05	V	$I_C = -2.5\text{A}, I_B = -250\text{mA}$
Output Capacitance	C_{obo}	-	19	25	pF	$V_{CB} = -10\text{V}, f = 1\text{MHz}$
Transition Frequency	f_T	150	190	-	MHz	$V_{CE} = -10\text{V}, I_C = -50\text{mA}, f = 100\text{MHz}$
Turn-on Time	t_{on}	-	40	-	ns	$V_{CC} = -15\text{V}, I_C = -0.75\text{A}$
Turn-off Time	t_{off}	-	435	-	ns	$I_{B1} = I_{B2} = -10\text{mA}$

Notes: 4. Measured under pulsed conditions.

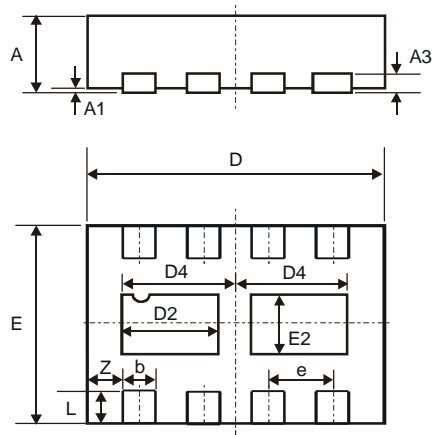
PNP Characteristics



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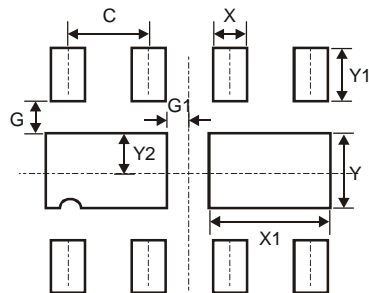
ZXTC6719MC

Package Outline Dimensions



DFN3020B-8			
Dim	Min	Max	Typ
A	0.77	0.83	0.80
A1	0	0.05	0.02
A3	-	-	0.15
b	0.25	0.35	0.30
D	2.95	3.075	3.00
D2	0.82	1.02	0.92
D4	1.01	1.21	1.11
e	-	-	0.65
E	1.95	2.075	2.00
E2	0.43	0.63	0.53
L	0.25	0.35	0.30
Z	-	-	0.375
All Dimensions in mm			

Suggested Pad Layout



Dimensions	Value (in mm)
C	0.650
G	0.285
G1	0.090
X	0.400
X1	1.120
Y	0.730
Y1	0.500
Y2	0.365

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